

**Search Notes**

Application/Control No.

10/081,203

Examiner

Marc R. Filipczyk

Applicant(s)/Patent under  
Reexamination

MATSUBAYASHI ET AL.

Art Unit

2163

**SEARCHED**

Class	Subclass	Date	Examiner
707	1-10	11/16/2006	MF
715	500, 511	11/16/2006	MF

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
707	3	11/16/2006	MF
707	1, 2	11/16/2006	MF
715	500	11/16/2006	MF

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST; IEEE; CiteSeer; extract/parse, search, weight, position, vectors, cosine, similarity; consulted A. Kinred (AU2163)	11/16/2006	MF
consulted C. Paula (AU2178)	11/16/2006	MF